



14 Output, 3.3V SDRAM Buffer for Desktop PCs with 3 DIMMs

Features

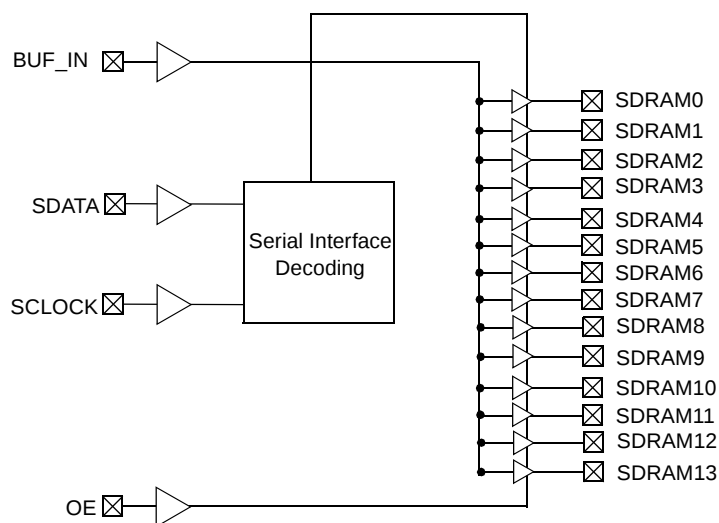
- One input to 14 output buffer/driver
- Supports up to three SDRAM DIMMs
- Two additional outputs for feedback
- Serial interface for output control
- Low skew outputs
- Up to 100-MHz operation
- Multiple V_{DD} and V_{SS} pins for noise reduction
- Dedicated OE pin for testing
- Low EMI outputs
- 28-pin SOIC (300-mil) package
- 3.3V operation

Functional Description

The CY2314ANZ is a 3.3V buffer designed to distribute high-speed clocks in desktop PC applications. The part has 14 outputs, 12 of which can be used to drive up to three SDRAM DIMMs, and the remaining can be used for external feedback to a PLL. The device operates at 3.3V and outputs can run up to 100 MHz, thus making it compatible with Pentium® II processors. The CY2314ANZ can be used in conjunction with the CY2280, CY2281, CY2282 or similar clock synthesizer for a complete Pentium II motherboard solution.

The CY2314ANZ also includes a serial interface which can enable or disable each output clock. On power-up, all output clocks are enabled. A separate Output Enable pin facilitates testing on ATE.

Block Diagram



Pin Configuration

28-pin SOIC Top View			
V_{DD}	1	28	V_{DD}
SDRAM0	2	27	SDRAM11
SDRAM1	3	26	SDRAM10
V_{SS}	4	25	V_{SS}
V_{DD}	5	24	V_{DD}
SDRAM2	6	23	SDRAM9
SDRAM3	7	22	SDRAM8
V_{SS}	8	21	V_{SS}
BUF_IN	9	20	OE
SDRAM4	10	19	SDRAM7
SDRAM5	11	18	SDRAM6
SDRAM12	12	17	SDRAM13
V_{DDIIC}	13	16	V_{SSIIC}
SDATA	14	15	SCLK

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Pin Summary

Name	Pins	Description
V _{DD}	1, 5, 24, 28	3.3V Digital voltage supply
V _{SS}	4, 8, 21, 25	Ground
V _{DDIIC}	13	Serial interface voltage supply
V _{SSIIC}	16	Ground for serial interface
BUF_IN	9	Input clock
OE	20	Output Enable, three-states outputs when LOW. Internal pull-up to V _{DD}
SDATA	14	Serial data input, internal pull-up to V _{DD}
SCLK	15	Serial clock input, internal pull-up to V _{DD}
SDRAM [0-13]	2, 3, 6, 7, 10, 11, 18, 19, 22, 23, 26, 27, 12, 17	SDRAM clock outputs

Device Functionality

OE	SDRAM [0-13]
0	High-Z
1	1 x BUF_IN

Serial Configuration Map

- The Serial bits will be read by the clock driver in the following order:

Byte 0 - Bits 7, 6, 5, 4, 3, 2, 1, 0

Byte 1 - Bits 7, 6, 5, 4, 3, 2, 1, 0

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Byte N - Bits 7, 6, 5, 4, 3, 2, 1, 0

- Reserved and unused bits should be programmed to "0"
- Serial interface address for the CY2314ANZ is:

A6	A5	A4	A3	A2	A1	A0	R/W
1	1	0	1	0	0	1	----

Byte 0:SDRAM Active/Inactive Register (1 = Enable, 0 = Disable), Default = Enabled

Bit	Pin #	Description
Bit 7	11	SDRAM5 (Active/Inactive)
Bit 6	10	SDRAM4 (Active/Inactive)
Bit 5	--	Reserved, drive to 0
Bit 4	--	Reserved, drive to 0
Bit 3	7	SDRAM3 (Active/Inactive)
Bit 2	6	SDRAM2 (Active/Inactive)
Bit 1	3	SDRAM1 (Active/Inactive)
Bit 0	2	SDRAM0 (Active/Inactive)

Byte 1: SDRAM Active/Inactive Register (1 = Active, 0 = Inactive), Default = Active

Bit	Pin #	Description
Bit 7	27	SDRAM11 (Active/Inactive)
Bit 6	26	SDRAM10 (Active/Inactive)
Bit 5	23	SDRAM9 (Active/Inactive)
Bit 4	22	SDRAM8 (Active/Inactive)
Bit 3	--	Reserved, drive to 0
Bit 2	--	Reserved, drive to 0
Bit 1	19	SDRAM7 (Active/Inactive)
Bit 0	18	SDRAM6 (Active/Inactive)

Byte 2: SDRAM Active/Inactive Register (1 = Active, 0 = Inactive), Default = Active

Bit	Pin #	Description
Bit 7	17	SDRAM13 (Active/Inactive)
Bit 6	12	SDRAM12 (Active/Inactive)
Bit 5	--	Reserved, drive to 0
Bit 4	--	Reserved, drive to 0
Bit 3	--	Reserved, drive to 0
Bit 2	--	Reserved, drive to 0
Bit 1	--	Reserved, drive to 0
Bit 0	--	Reserved, drive to 0

Maximum Ratings

Supply Voltage to Ground Potential -0.5V to +7.0V
 DC Input Voltage (Except BUF_IN) -0.5V to $V_{DD} + 0.5V$
 DC Input Voltage (BUF_IN) -0.5V to +7.0V

Storage Temperature -65°C to +150°C
 Junction Temperature 150°C
 Static Discharge Voltage
 (per MIL-STD-883, Method 3015) >2000V

Operating Conditions ^[1]

Parameter	Description	Min.	Max.	Unit
V_{DD}	Supply Voltage	3.135	3.465	V
T_A	Operating Temperature (Ambient Temperature)	0	70	°C
C_L	Load Capacitance		30	pF
C_{IN}	Input Capacitance		7	pF
t_{PU}	Power-up time for all VDD's to reach minimum specified voltage (power ramps must be monotonic)	0.05	50	ms

Electrical Characteristics Over the Operating Range

Parameter	Description	Test Conditions	Min.	Max.	Unit
V_{IL}	Input LOW Voltage ^[2]	Except serial interface pins		0.8	V
V_{ILiic}	Input LOW Voltage	For serial interface pins only		0.7	V
V_{IH}	Input HIGH Voltage ^[2]		2.0		V
I_{IL}	Input LOW Current (BUF_IN input)	$V_{IN} = 0V$	-10	10	μA
I_{IL}	Input LOW Current (Except BUF_IN Pin)	$V_{IN} = 0V$		100	μA
I_{IH}	Input HIGH Current	$V_{IN} = V_{DD}$	-10	10	μA
V_{OL}	Output LOW Voltage ^[3]	$I_{OL} = 25\text{ mA}$		0.4	V
V_{OH}	Output HIGH Voltage ^[3]	$I_{OH} = -36\text{ mA}$	2.4		V
I_{DD}	Supply Current ^[3]	Unloaded outputs, 100 MHz		200	mA
I_{DD}	Supply Current ^[3]	Loaded outputs, 100 MHz		290	mA
I_{DD}	Supply Current ^[3]	Unloaded outputs, 66.67 MHz		150	mA
I_{DD}	Supply Current ^[3]	Loaded outputs, 66.67 MHz		185	mA
I_{DDS}	Supply Current	BUF_IN= V_{DD} or V_{SS} All other inputs at V_{DD}		500	μA

Notes:

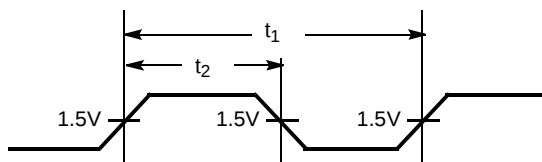
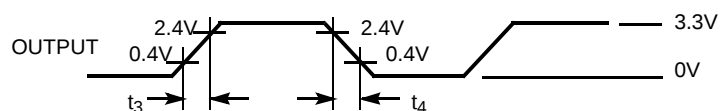
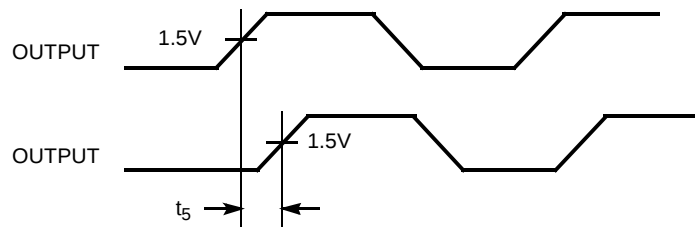
1. Electrical parameters are guaranteed under the operating conditions specified.
2. BUF_IN input has a threshold voltage of $V_{DD}/2$.
3. Parameter is guaranteed by design and characterization. Not 100% tested in production.

Switching Characteristics^[4] Over the Operating Range

Parameter	Name	Test Conditions	Min.	Typ.	Max.	Unit
	Maximum Operating Frequency				100	MHz
	Duty Cycle ^[3, 5] = $t_2 \div t_1$	Measured at 1.5V	45.0	50.0	55.0	%
t_3	Rising Edge Rate ^[3]	Measured between 0.4V and 2.4V	0.9	1.5	4.0	V/ns
t_4	Falling Edge Rate ^[3]	Measured between 2.4V and 0.4V	0.9	1.5	4.0	V/ns
t_5	Output to Output Skew ^[3]	All outputs equally loaded	-250		+250	ps
t_6	SDRAM Buffer LH Prop. Delay ^[3]	Input edge greater than 1 V/ns	1.0	3.5	5.0	ns
t_7	SDRAM Buffer HL Prop. Delay ^[3]	Input edge greater than 1 V/ns	1.0	3.5	5.0	ns
t_8	SDRAM Buffer Enable Delay ^[3]	Input edge greater than 1 V/ns	1.0	5	12	ns
t_9	SDRAM Buffer Disable Delay ^[3]	Input edge greater than 1 V/ns	1.0	20	30	ns

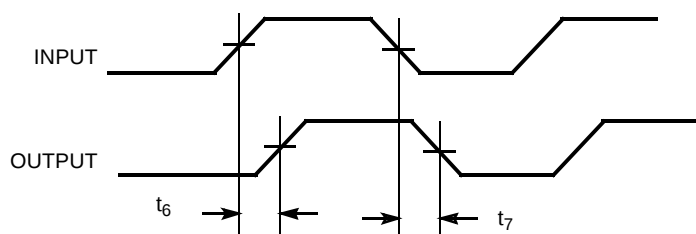
Notes:

4. All parameters specified with loaded outputs.
5. Duty cycle of input clock is 50%. Rising and falling edge rate of the input clock is greater than 1 V/ns.

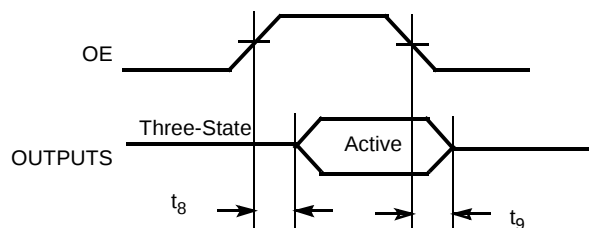
Switching Waveforms
Duty Cycle Timing

All Outputs Rise/Fall Time

Output-Output Skew


Switching Waveforms (continued)

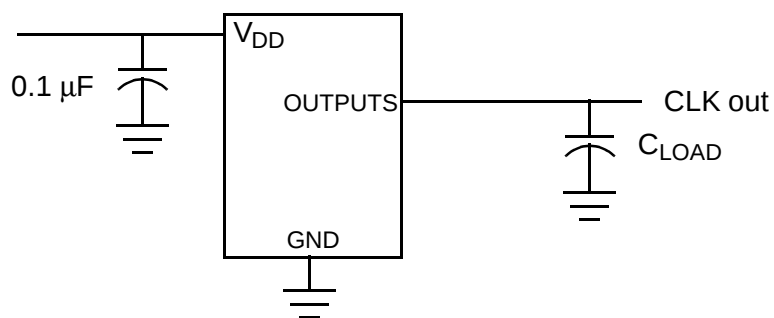
SDRAM Buffer LH and HL Propagation Delay



SDRAM Buffer Enable and Disable Times

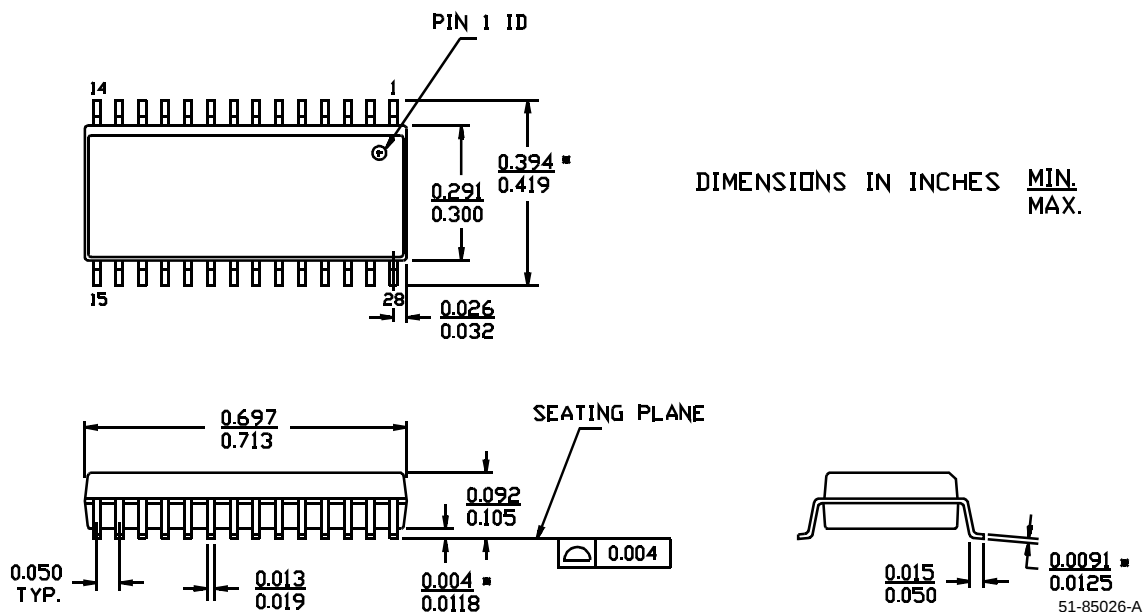


Test Circuit



Package Diagram

28-Lead (300-Mil) Molded SOIC S21



Document Title: CY2314ANZ 14 Output, 3.3V SDRAM Buffer for Desktop PCs with 3 DIMMs Document Number: 38-07143				
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change
**	110252	11/18/01	DSG	Change from Spec number: 38-00687 to 38-07143
*A	121830	12/14/02	RBI	Power up requirements added to Operating Conditions Information